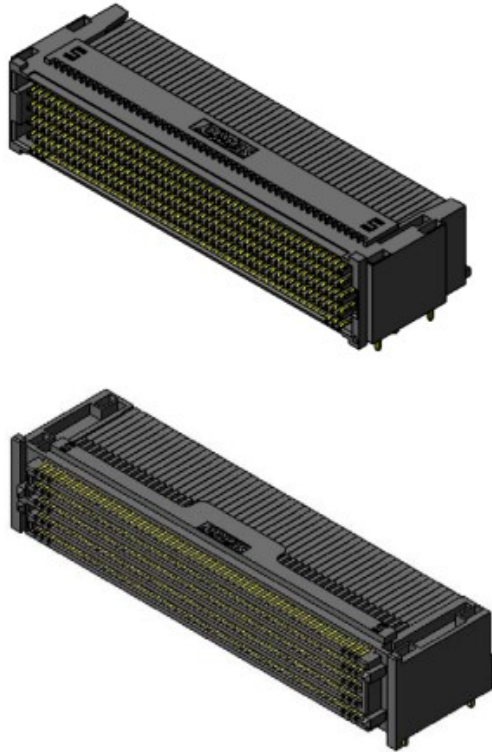




Project: Extended Life Qualification Test Report	Tracking Code: CR-1063202_Report_Rev_1
Requested by: Xuan Dong	Date: 8/8/2025
Part #: SEAF-50-01-S-10-2-RA-K-TR/ SEAM-50-01-S-10-2-RA-K-TR	Tech: Tony Wagoner
Part description: SEAF / SEAM	
Test Start: 3/25/2024	Test Completed: 7/15/2024



## Extended Life Qualification Test Report

SEAF / SEAM

SEAF-50-01-S-10-2-RA-K-TR/ SEAM-50-01-S-10-2-RA-K-TR

Tracking Code: CR-1063202_Report_Rev_1	Part #: SEAF-50-01-S-10-2-RA-K-TR/ SEAM-50-01-S-10-2-RA-K-TR
Part description: SEAF / SEAM	

**REVISION HISTORY**

<b>DATA</b>	<b>REV.NUM.</b>	<b>DESCRIPTION</b>	<b>ENG</b>
1/7/2025	1	Initial Issue	PC

## CERTIFICATION

All instruments and measuring equipment were calibrated to National Institute for Standards and Technology (NIST) traceable standards according to ISO 10012-1 and ANSI/NCSL 2540-1, as applicable.

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### SCOPE

To perform the following tests: Design Qualification test. Please see test plan.

### APPLICABLE DOCUMENTS

Standards: EIA-364.

### TEST SAMPLES AND PREPARATION

- 1) All materials were manufactured in accordance with the applicable product specification.
- 2) All test samples were identified and encoded to maintain traceability throughout the test sequences.
- 3) After soldering, the parts to be used for LLCRC was cleaned according to TLWI-0001.
- 4) Either an automated cleaning procedure or an ultrasonic cleaning procedure may be used.
- 5) The automated procedure is used with aqueous compatible soldering materials.
- 6) Parts not intended for testing LLCRC is visually inspected and cleaned if necessary.
- 7) Any additional preparation will be noted in the individual test sequences.
- 8) Solder Information: Lead Free

**FLOWCHARTS****Extended Life**Group 3

SEAF-50-01-S-10-2-RA-K-TR  
SEAM-50-01-S-10-2-RA-K-TR  
8 Assemblies  
500 Cycles

Step	Description
1.	Plating Thickness Verification <sup>(4)</sup>
2.	LLCR <sup>(2)</sup>
3.	Cycles Quantity = 500 Cycles
4.	LLCR <sup>(2)</sup> Max Delta = 15 mOhm
5.	Thermal Shock <sup>(5)</sup>
6.	LLCR <sup>(2)</sup> Max Delta = 15 mOhm
7.	Humidity <sup>(1)</sup>
8.	LLCR <sup>(2)</sup> Max Delta = 15 mOhm
9.	Photos <sup>(3)</sup>

Group 4

SEAF-50-01-S-10-2-RA-K-TR  
SEAM-50-01-S-10-2-RA-K-TR  
8 Assemblies  
1000 Cycles

Step	Description
1.	Plating Thickness Verification <sup>(4)</sup>
2.	LLCR <sup>(2)</sup>
3.	Cycles Quantity = 1000 Cycles
4.	LLCR <sup>(2)</sup> Max Delta = 15 mOhm
5.	Thermal Shock <sup>(5)</sup>
6.	LLCR <sup>(2)</sup> Max Delta = 15 mOhm
7.	Humidity <sup>(1)</sup>
8.	LLCR <sup>(2)</sup> Max Delta = 15 mOhm
9.	Photos <sup>(3)</sup>

(1) Humidity = EIA-364-31

Test Condition = B (240 Hours)

Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)

Test Exceptions: ambient pre-condition and delete steps 7a and 7b

(2) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(3) Photos

Attach 2-3 photos of contact area

(4) Plating Thickness Verification

Measure, verify, and document plating thickness on both male and female (one group only)

Plating thickness to be measured on loose pins used during assembly

(5) Thermal Shock = EIA-364-32

Exposure Time at Temperature Extremes = 1/2 Hour

Method A, Test Condition = I (-55°C to +85°C)

Test Duration = A-3 (100 Cycles)

## ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

### THERMAL SHOCK:

- 1) MIL-PRF-39012, *Paragraph. 4.6.17 per MIL-STD-202-107*
- 2) Test Condition: I (-55°C to +85°C)
- 3) Test Time: ½ hour dwell at each temperature extreme
- 4) Test Duration: Test condition A-3 = 100 Cycles.
- 5) All test samples are pre-conditioned at ambient.
- 6) All test samples are exposed to environmental stressing in the mated condition.

### LLCR:

- 1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.*
- 2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
  - a.  $\leq +5.0$  mOhms: -----Stable
  - b.  $+5.1$  to  $+10.0$  mOhms:-----Minor
  - c.  $+10.1$  to  $+15.0$  mOhms: -----Acceptable
  - d.  $+15.1$  to  $+50.0$  mOhms: -----Marginal
  - e.  $+50.1$  to  $+1000$  mOhms: -----Unstable
  - f.  $>+1000$  mOhms:-----Open Failure

### HUMIDITY:

- 1) Reference document: EIA-364-31, *Humidity Test Procedure for Electrical Connectors.*
- 2) Test Condition B, 240 Hours.
- 3) Method III,  $+25^{\circ}$  C to  $+65^{\circ}$  C, 90% to 98% Relative Humidity excluding sub-cycles 7a and 7b.
- 4) All samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

**RESULTS**

**LLCR Extended Life Group (192 LLCR test points)**

**500 cycles**

**Signal type 1**

- **Initial** ----- 10.21 mOhms Max

**Signal type 2**

- **Initial** ----- 14.15 mOhms Max

**Signal type 3**

- **Initial** ----- 19.17 mOhms Max

**Signal type 4**

- **Initial** ----- 25.53 mOhms Max
- **Durability, 500 Cycles**
  - **<= +5.0 mOhms** ----- 192 Points ----- Stable
  - **+5.1 to +10.0 mOhms** ----- 0 Points ----- Minor
  - **+10.1 to +15.0 mOhms** ----- 0 Points ----- Acceptable
  - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
  - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
  - **>+2000 mOhms** ----- 0 Points ----- Open Failure
- **Thermal Shock**
  - **<= +5.0 mOhms** ----- 192 Points ----- Stable
  - **+5.1 to +10.0 mOhms** ----- 0 Points ----- Minor
  - **+10.1 to +15.0 mOhms** ----- 0 Points ----- Acceptable
  - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
  - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
  - **>+2000 mOhms** ----- 0 Points ----- Open Failure
- **Humidity**
  - **<= +5.0 mOhms** ----- 188 Points ----- Stable
  - **+5.1 to +10.0 mOhms** ----- 3 Points ----- Minor
  - **+10.1 to +15.0 mOhms** ----- 1 Points ----- Acceptable
  - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
  - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
  - **>+2000 mOhms** ----- 0 Points ----- Open Failure

**RESULTS Continued**

**LLCR Extended Life Group (192 LLCR test points)**

**1000 cycles**

**Signal type 1**

- **Initial** ----- 10.56 mOhms Max

**Signal type 2**

- **Initial** ----- 14.85 mOhms Max

**Signal type 3**

- **Initial** ----- 19.47 mOhms Max

**Signal type 4**

- **Initial** ----- 25.39 mOhms Max
- **Durability, 100 Cycles**
  - **<= +5.0 mOhms** ----- 192 Points ----- Stable
  - **+5.1 to +10.0 mOhms** ----- 0 Points ----- Minor
  - **+10.1 to +15.0 mOhms** ----- 0 Points ----- Acceptable
  - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
  - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
  - **>+2000 mOhms** ----- 0 Points ----- Open Failure
- **Thermal Shock**
  - **<= +5.0 mOhms** ----- 192 Points ----- Stable
  - **+5.1 to +10.0 mOhms** ----- 0 Points ----- Minor
  - **+10.1 to +15.0 mOhms** ----- 0 Points ----- Acceptable
  - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
  - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
  - **>+2000 mOhms** ----- 0 Points ----- Open Failure
- **Humidity**
  - **<= +5.0 mOhms** ----- 189 Points ----- Stable
  - **+5.1 to +10.0 mOhms** ----- 2 Points ----- Minor
  - **+10.1 to +15.0 mOhms** ----- 1 Points ----- Acceptable
  - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
  - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
  - **>+2000 mOhms** ----- 0 Points ----- Open Failure

**DATA SUMMARIES**

**LLCR Extended Life**

- 1). A total of 192 points were measured.
- 2). EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3). The following guidelines are used to categorize the changes in LLCR as a result from stressing.
  - a.  $\leq +5.0$  mOhms: -----Stable
  - b.  $+5.1$  to  $+10.0$  mOhms: -----Minor
  - c.  $+10.1$  to  $+15.0$  mOhms: -----Acceptable
  - d.  $+15.1$  to  $+50.0$  mOhms: -----Marginal
  - e.  $+50.1$  to  $+1000$  mOhms -----Unstable
  - f.  $>+1000$  mOhms: -----Open Failure

**500 Cycles**

LLCR Measurement Summaries by Pin Type				
Date	6/12/2024	6/18/2024	7/1/2024	7/12/2024
Room Temp (Deg C)	22	22	22	22
Rel Humidity (%)	44	53	48	54
Technician	Tony Wagoner	Matthew Gramlin	Tony Wagoner	Richard Ison
<b>mOhm values</b>				
	<b>Actual</b>	<b>Delta</b>	<b>Delta</b>	<b>Delta</b>
	<b>Initial</b>	<b>500 Cycles</b>	<b>Therm Shck</b>	<b>Humidity</b>
<b>Pin Type: Signal 1</b>				
Average	8.74	0.31	0.35	1.39
St. Dev.	0.69	0.27	0.26	2
Min	7.45	0	0	0.12
Max	10.21	1.22	1.07	11.16
Summary Count	32	32	32	32
Total Count	32	32	32	32
<b>Pin Type: Signal 2</b>				
Average	12.46	0.34	0.33	1.05
St. Dev.	1.1	0.22	0.24	0.9
Min	10.07	0	0	0.02
Max	14.15	0.9	1.13	5.05
Summary Count	56	56	56	56
Total Count	56	56	56	56
<b>Pin Type: Signal 3</b>				
Average	16.78	0.32	0.32	0.45
St. Dev.	1.26	0.25	0.33	0.37
Min	14.76	0.01	0.02	0.01
Max	19.17	1.11	1.91	2.11
Summary Count	64	64	64	64
Total Count	64	64	64	64
<b>Pin Type: Signal 4</b>				
Average	23.26	0.34	0.42	0.94
St. Dev.	1.75	0.4	0.34	1.29
Min	20.11	0	0.01	0
Max	25.53	1.77	1.41	5.36

Tracking Code: CR-1063202_Report_Rev_1	Part #: SEAF-50-01-S-10-2-RA-K-TR/ SEAM-50-01-S-10-2-RA-K-TR
Part description: SEAF / SEAM	

Summary Count	40	40	40	40
Total Count	40	40	40	40

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	<=5	>5 & <=10	>10 & <=15	>15 & <=50	>50 & <=1000	>1000
500 Cycles	192	0	0	0	0	0
Therm Shck	192	0	0	0	0	0
Humidity	188	3	1	0	0	0

**DATA SUMMARIES Continued**

**1000 Cycles**

LLCR Measurement Summaries by Pin Type				
Date	6/12/2024	6/20/2024	7/5/2024	7/23/2024
Room Temp (Deg C)	22	22	22	22
Rel Humidity (%)	41	55	55	54
Technician	Tony Wagoner	Tony Wagoner	Richard Ison	Tony Wagoner
mOhm values				
	Actual Initial	Delta 1000 Cycles	Delta Therm Shck	Delta Humidity
Pin Type: Signal 1				
Average	8.77	0.41	0.39	1.74
St. Dev.	0.76	0.21	0.29	3.08
Min	7.64	0.02	0	0.02
Max	10.56	1	1.31	14.93
Summary Count	32	32	32	32
Total Count	32	32	32	32
Pin Type: Signal 2				
Average	12.59	0.46	0.49	0.66
St. Dev.	1.16	0.35	0.38	0.6
Min	9.99	0.03	0.01	0.04
Max	14.85	1.77	1.46	3.6
Summary Count	56	56	56	56
Total Count	56	56	56	56
Pin Type: Signal 3				
Average	16.85	0.36	0.49	0.59
St. Dev.	1.26	0.29	0.34	0.59
Min	14.86	0	0.02	0
Max	19.47	1.28	1.43	4.24
Summary Count	64	64	64	64
Total Count	64	64	64	64
Pin Type: Signal 4				
Average	23.31	0.39	0.71	0.63
St. Dev.	1.76	0.34	0.38	0.7
Min	20.12	0.01	0.1	0
Max	25.39	1.38	1.43	3.25
Summary Count	40	40	40	40
Total Count	40	40	40	40

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
<b>mOhms</b>	<b>&lt;=5</b>	<b>&gt;5 &amp; &lt;=10</b>	<b>&gt;10 &amp; &lt;=15</b>	<b>&gt;15 &amp; &lt;=50</b>	<b>&gt;50 &amp; &lt;=1000</b>	<b>&gt;1000</b>
<b>1000 Cycles</b>	<b>192</b>	<b>0</b>	<b>0</b>	<b>0</b>	<b>0</b>	<b>0</b>
<b>Therm Shck</b>	<b>192</b>	<b>0</b>	<b>0</b>	<b>0</b>	<b>0</b>	<b>0</b>
<b>Humidity</b>	<b>189</b>	<b>2</b>	<b>1</b>	<b>0</b>	<b>0</b>	<b>0</b>

**EQUIPMENT AND CALIBRATION SCHEDULES****Equipment #:** TCT-04**Description:** Dillon Quantrol TC21 25-1000 mm/min series test stand**Manufacturer:** Dillon Quantrol**Model:** TC2 I series test stand**Serial #:** 04-1041-04**Accuracy:** Speed Accuracy: +/- 5% of indicated speed; Speed Accuracy: +/- 5% of indicated speed;  
... Last Cal: 05/29/2024, Next Cal: 05/29/2025**Equipment #:** THC-01**Description:** Humidity transmitter**Manufacturer:** Thermtron**Model:** SM-8-8200**Serial #:** 38846**Accuracy:** Last Cal: 2/28/2024, Next Cal: 2/27/2025**Equipment #:** TSC-01**Description:** Vertical Thermal Shock Chamber**Manufacturer:** Cincinnati Sub Zero**Model:** VTS-3-6-6-SC/AC**Serial #:** 10-VT14993**Accuracy:** See Manual

... Last Cal: 06/30/2024, Next Cal: 06/30/2025

**Equipment #:** MO-04**Description:** Multimeter /Data Acquisition System**Manufacturer:** Keithley**Model:** 2700**Serial #:** 0798688**Accuracy:** See Manual

... Last Cal: 04/30/2024, Next Cal: 04/30/2025